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REQUEST	Application Number	037 1 2 3 2
FOR	Filing Date	November 17, 1999
CONTINUED EXAMINATION (RCE)	First Named Inventor	Mark E. Lewis
TRANSMITTAL	Art Unit	1743
Address to:	Examiner Name	Latoya I. Cross
Commissioner for Patents  Box RCE	Attorney Docket Number	
Washington, DC 20231		it wifed emplication
This is a Request for Continued Examination (RCE) under 37 (Request for Continued Examination (RCE) practice under 37 CFR 1.114 does not 1995, or to any design application. See Instruction Sheet for RCEs (not to be subsequent to any design application. See Instruction Sheet for RCEs (not to be subsequent to any design application. See Instruction Sheet for RCEs (not to be subsequent to any design application. See Instruction Sheet for RCEs (not to be subsequent to any design application. Submission required under 37 CFR 1.114  a. Previously submitted i. Consider the amendment(s)/reply under 37 CFR 1. ii. Consider the arguments in the Appeal Brief or Replication. Submission of the Appeal Brief or Replication. Submission of action on the above-identified application. Submission of the period of suspension shall not be considered as a submission of the required by 37 CFR 1.114 when the period of the RCE fee under 37 CFR 1.17(e) is required by 37 CFR 1.114 when the Deposit Account No. O1-0025 i. RCE fee required under 37 CFR 1.136 and 1.17)	. 116 previously filed on by Brief previously filed on Information Disclose Other Two Moreon is requested under exceed 3 months; Fee under 3	ure Statement (IDS)  hth Extension of Time  37 CFR 1.103(c) for a
b. Check in the amount of \$end c. Payment by credit card (Form PTO-2038 enclosed)  WARNING: Information on this form may become be included on this form. Provide credit card info	public. Credit card i rmation and authoriz	
	Registration No.	(Attomey/Agent) 28128
Name (Print/Type) David L. Weinstein		iber 11, 2002
Signature Daniel L. Kennster		
CERTIFICATE OF MAILING  I hereby certify that this correspondence is being deposited with the United St.  Commissioner For Patents, Box RCE, Washington, D.	ates Postal Service with suf	ficient postage as first class mail in an
Office on the date shown below.	C 20231, or facsimile transr	nitted to the U.S. Patent and Trademark
Name (Print/Type) Michele M. Bonkle  Out to Date December 11, 2002		
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THE UNITED STATES PATENT AND TRADEMARK OFFICE

cant: M. E. Lewis, et al.

Serial No: 09/441,674 🗸

Filed: November 17, 1999

For: MULTICHEMISTRY MEASURING

DEVICE AND TEST STRIPS

Group Art Unit: 1743

Examiner: Cross, L.

File No.: 6622.US.O1

Date: December 11, 2002

Certificate f Mailing (37 CFR 1.8(a))

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the:

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Assistant Commissioner for Patents Washington, D.C. 20231, on:

Date of Deposit: Decembe

AMENDMENT AND RESPONSE ACCOMPANYING REQUEST FOR CONTINUED EXAMINATION PECEIVED
TO 1700

The Commissioner of Patents and Trademarks Washington, D. C. 20231

Dear Sir:

In response to the Final Rejection mailed July 17, 2002, the period for response to which has been extended to December 17, 2002 by means of a Request for Continued Examination, please amend the above-identified application as follows:

IN THE CLAIMS

Kindly rewrite claims 1, 4-10, 15, 16, 20-22, 24, and 26-28 as follows:

A test strip for chemical analysis of a (Once amended) 1. sample, adapted for use in combination with a measuring device having a test

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